

<b>Notice of References Cited</b>	Application/Control No. 10/052,277	Applicant(s)/Patent Under Reexamination JENSEN, JENSEN HARTRUNG	
	Examiner Christopher E. Lee	Art Unit 2112	Page 1 of 1

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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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